

<b>Notice of References Cited</b>	Application/Control No. 10/736,329	Applicant(s)/Patent Under Reexamination NAKASHIMA ET AL.	
	Examiner David Turocy	Art Unit 1762	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,316,130	11-2001	Heuer et al.	428/690
	B	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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